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Title:1550 nm ErAs:In(Al)GaAs large area photoconductive emitters

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Abstract:We report on high power terahertz (THz) emission from ErAs-enhanced In inf0.52/infAlinf0.48/infAs-Ininf0.53/infGainf0.47/inf As superlattices for operation at 1550 nm. ErAs clusters act as efficient recombination centers. The optical power is distributed among a large, microstructured area in order to reduce the local optical intensity. A THz field strength of 0.7 V/cm (1 V/cm peak-to-peak) at 100 mW average optical power has been obtained, with emission up to about 4 THz in air, limited by the detection crystal used in the system. © 2012 American Institute of Physics.

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Controlled terms: Physical properties

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